

## N - CHANNEL ENHANCEMENT MODE LOW THRESHOLD POWER MOS TRANSISTOR

| TYPE      | V <sub>DSS</sub> | R <sub>DS(on)</sub> | I <sub>D</sub> |
|-----------|------------------|---------------------|----------------|
| STD12N05L | 50 V             | < 0.15 Ω            | 12 A           |
| STD12N06L | 60 V             | < 0.15 Ω            | 12 A           |

- TYPICAL R<sub>DS(on)</sub> = 0.115 Ω
- AVALANCHE RUGGED TECHNOLOGY
- 100% AVALANCHE TESTED
- REPETITIVE AVALANCHE DATA AT 100°C
- LOW GATE CHARGE
- LOGIC LEVEL COMPATIBLE INPUT
- 175°C OPERATING TEMPERATURE
- APPLICATION ORIENTED CHARACTERIZATION
- THROUGH-HOLE IPAK (TO-251) POWER PACKAGE IN TUBE (SUFFIX "-1")
- SURFACE-MOUNTING DPAK (TO-252) POWER PACKAGE IN TAPE & REEL (SUFFIX "T4")

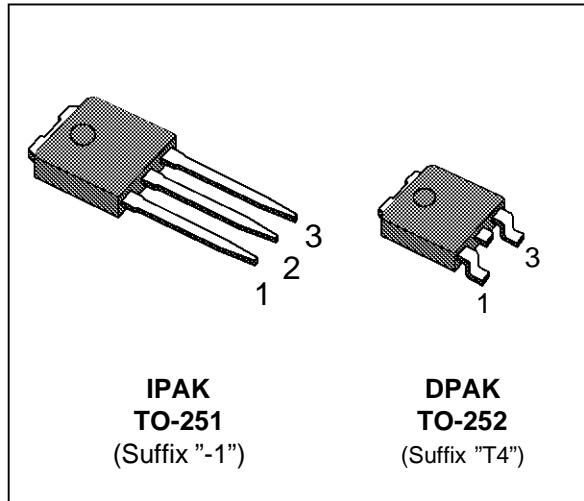
### APPLICATIONS

- HIGH CURRENT, HIGH SPEED SWITCHING
- SOLENOID AND RELAY DRIVERS
- REGULATORS
- DC-DC & DC-AC CONVERTERS
- MOTOR CONTROL, AUDIO AMPLIFIERS
- AUTOMOTIVE ENVIRONMENT (INJECTION, ABS, AIR-BAG, LAMPDRIVERS, Etc.)

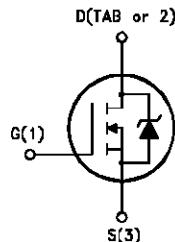
### ABSOLUTE MAXIMUM RATINGS

| Symbol             | Parameter   | Value      |           | Unit |
|--------------------|---|------------|-----------|------|
|                    |   | STD12N05L  | STD12N06L |      |
| V <sub>DS</sub>    | Drain-source Voltage (V <sub>GS</sub> = 0)            | 50         | 60        | V    |
| V <sub>DGR</sub>   | Drain- gate Voltage (R <sub>GS</sub> = 20 kΩ)         | 50         | 60        | V    |
| V <sub>GS</sub>    | Gate-source Voltage                                   | ± 15       |           | V    |
| I <sub>D</sub>     | Drain Current (continuous) at T <sub>c</sub> = 25 °C  | 12         |           | A    |
| I <sub>D</sub>     | Drain Current (continuous) at T <sub>c</sub> = 100 °C | 8          |           | A    |
| I <sub>DM(•)</sub> | Drain Current (pulsed)                                | 48         |           | A    |
| P <sub>tot</sub>   | Total Dissipation at T <sub>c</sub> = 25 °C           | 45         |           | W    |
|                    | Derating Factor                                       | 0.3        |           | W/°C |
| T <sub>stg</sub>   | Storage Temperature                                   | -65 to 175 |           | °C   |
| T <sub>j</sub>     | Max. Operating Junction Temperature                   | 175        |           | °C   |

(•) Pulse width limited by safe operating area



### INTERNAL SCHEMATIC DIAGRAM



## STD12N05L/STD12N06L

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### THERMAL DATA

|                |  |     |      |                             |
|----------------|--|-----|------|-----------------------------|
| $R_{thj-case}$ | Thermal Resistance Junction-case               | Max | 3.33 | $^{\circ}\text{C}/\text{W}$ |
| $R_{thj-amb}$  | Thermal Resistance Junction-ambient            | Max | 100  | $^{\circ}\text{C}/\text{W}$ |
| $R_{thc-sink}$ | Thermal Resistance Case-sink                   | Typ | 1.5  | $^{\circ}\text{C}/\text{W}$ |
| $T_L$          | Maximum Lead Temperature For Soldering Purpose |     | 275  | $^{\circ}\text{C}$          |

### AVALANCHE CHARACTERISTICS

| Symbol   | Parameter  | Max Value | Unit |
|----------|--|-----------|------|
| $I_{AR}$ | Avalanche Current, Repetitive or Not-Repetitive (pulse width limited by $T_j$ max, $\delta < 1\%$ )                                | 12        | A    |
| $E_{AS}$ | Single Pulse Avalanche Energy (starting $T_j = 25^{\circ}\text{C}$ , $I_D = I_{AR}$ , $V_{DD} = 25\text{ V}$ )                     | 30        | mJ   |
| $E_{AR}$ | Repetitive Avalanche Energy (pulse width limited by $T_j$ max, $\delta < 1\%$ )  | 7         | mJ   |
| $I_{AR}$ | Avalanche Current, Repetitive or Not-Repetitive ( $T_c = 100^{\circ}\text{C}$ , pulse width limited by $T_j$ max, $\delta < 1\%$ ) | 8         | A    |

### ELECTRICAL CHARACTERISTICS ( $T_{case} = 25^{\circ}\text{C}$ unless otherwise specified)

#### OFF

| Symbol        | Parameter  | Test Conditions   | Min.     | Typ. | Max.      | Unit                           |
|---------------|--|---|----------|------|-----------|--------------------------------|
| $V_{(BR)DSS}$ | Drain-source Breakdown Voltage                   | $I_D = 250\text{ }\mu\text{A}$ $V_{GS} = 0$<br>for <b>STD12N05L</b><br>for <b>STD12N06L</b>         | 50<br>60 |      |           | V<br>V                         |
| $I_{DSS}$     | Zero Gate Voltage Drain Current ( $V_{GS} = 0$ ) | $V_{DS} = \text{Max Rating}$<br>$V_{DS} = \text{Max Rating} \times 0.8$ $T_c = 125^{\circ}\text{C}$ |          |      | 1<br>10   | $\mu\text{A}$<br>$\mu\text{A}$ |
| $I_{GSS}$     | Gate-body Leakage Current ( $V_{DS} = 0$ )       | $V_{GS} = \pm 15\text{ V}$  |          |      | $\pm 100$ | nA                             |

#### ON (\*)

| Symbol       | Parameter                         | Test Conditions  | Min. | Typ.  | Max. | Unit     |
|--------------|-----------------------------------|--|------|-------|------|----------|
| $V_{GS(th)}$ | Gate Threshold Voltage            | $V_{DS} = V_{GS}$ $I_D = 250\text{ }\mu\text{A}$                     | 1    | 1.6   | 2.5  | V        |
| $R_{DS(on)}$ | Static Drain-source On Resistance | $V_{GS} = 5\text{ V}$ $I_D = 6\text{ A}$                             |      | 0.115 | 0.15 | $\Omega$ |
| $I_{D(on)}$  | On State Drain Current            | $V_{DS} > I_{D(on)} \times R_{DS(on)\max}$<br>$V_{GS} = 10\text{ V}$ | 12   |       |      | A        |

#### DYNAMIC

| Symbol                              | Parameter   | Test Conditions   | Min. | Typ.             | Max.             | Unit           |
|-------------------------------------|---|---|------|------------------|------------------|----------------|
| $g_{fs} (*)$                        | Forward Transconductance  | $V_{DS} > I_{D(on)} \times R_{DS(on)\max}$ $I_D = 6\text{ A}$ | 4    | 8                |                  | S              |
| $C_{iss}$<br>$C_{oss}$<br>$C_{rss}$ | Input Capacitance<br>Output Capacitance<br>Reverse Transfer Capacitance | $V_{DS} = 25\text{ V}$ $f = 1\text{ MHz}$ $V_{GS} = 0$        |      | 350<br>150<br>50 | 500<br>200<br>80 | pF<br>pF<br>pF |

## ELECTRICAL CHARACTERISTICS (continued)

### SWITCHING ON

| Symbol                        | Parameter  | Test Conditions  | Min. | Typ.         | Max.      | Unit                   |
|-------------------------------|--|--|------|--------------|-----------|------------------------|
| $t_{d(on)}$<br>$t_r$          | Turn-on Time<br>Rise Time                                    | $V_{DD} = 25 \text{ V}$ $I_D = 6 \text{ A}$<br>$R_G = 50 \Omega$ $V_{GS} = 5 \text{ V}$<br>(see test circuit, figure 3)  |      | 55<br>180    | 80<br>260 | ns<br>ns               |
| $(di/dt)_{on}$                | Turn-on Current Slope  | $V_{DD} = 40 \text{ V}$ $I_D = 12 \text{ A}$<br>$R_G = 50 \Omega$ $V_{GS} = 5 \text{ V}$<br>(see test circuit, figure 5) |      | 120          |           | $\text{A}/\mu\text{s}$ |
| $Q_g$<br>$Q_{gs}$<br>$Q_{gd}$ | Total Gate Charge<br>Gate-Source Charge<br>Gate-Drain Charge | $V_{DD} = 40 \text{ V}$ $I_D = 12 \text{ A}$ $V_{GS} = 5 \text{ V}$  |      | 12<br>6<br>5 | 18        | nC<br>nC<br>nC         |

## SWITCHING OFF

| Symbol                          | Parameter   | Test Conditions  | Min. | Typ.            | Max.            | Unit           |
|---------------------------------|---|--|------|-----------------|-----------------|----------------|
| $t_{r(Voff)}$<br>$t_f$<br>$t_c$ | Off-voltage Rise Time<br>Fall Time<br>Cross-over Time | $V_{DD} = 40 \text{ V}$ $I_D = 12 \text{ A}$<br>$R_G = 50 \Omega$ $V_{GS} = 5 \text{ V}$<br>(see test circuit, figure 5) |      | 40<br>60<br>110 | 60<br>90<br>160 | ns<br>ns<br>ns |

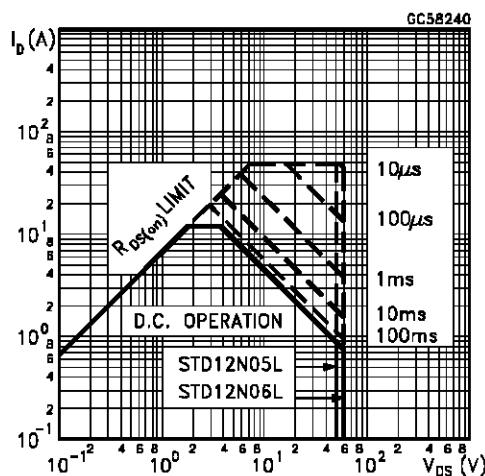
## SOURCE DRAIN DIODE

| Symbol                         | Parameter   | Test Conditions  | Min. | Typ. | Max.     | Unit          |
|--------------------------------|---|--|------|------|----------|---------------|
| $I_{SD}$<br>$I_{SDM}(\bullet)$ | Source-drain Current<br>Source-drain Current (pulsed) |  |      |      | 12<br>48 | A<br>A        |
| $V_{SD} (\ast)$                | Forward On Voltage                                    | $I_{SD} = 12 \text{ A}$ $V_{GS} = 0$   |      |      | 1.5      | V             |
| $t_{rr}$                       | Reverse Recovery Time                                 | $I_{SD} = 12 \text{ A}$ $di/dt = 100 \text{ A}/\mu\text{s}$<br>$V_{DD} = 25 \text{ V}$ $T_j = 150^\circ\text{C}$ |      | 75   |          | ns            |
| $Q_{rr}$                       | Reverse Recovery Charge                               | (see test circuit, figure 5)   |      | 0.15 |          | $\mu\text{C}$ |
| $I_{RRM}$                      | Reverse Recovery Current                              |  |      | 4    |          | A             |

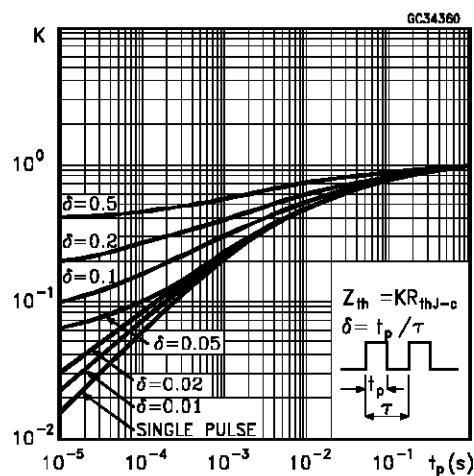
(\*) Pulsed: Pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5 %

(\*) Pulse width limited by safe operating area

## Safe Operating Areas

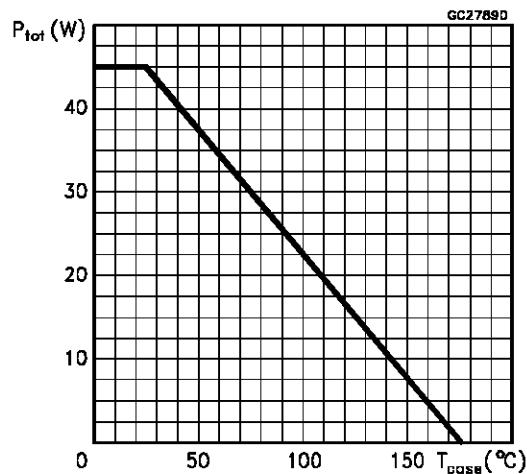


## Thermal Impedance

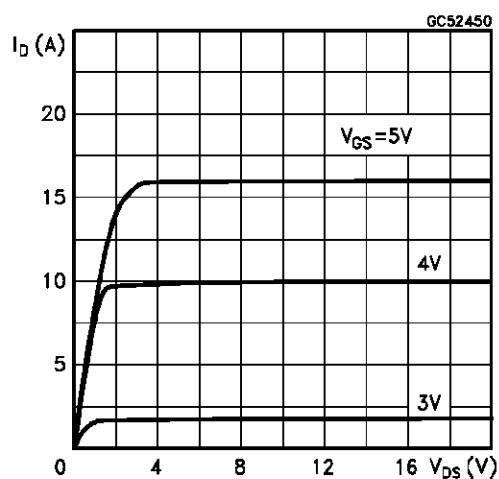


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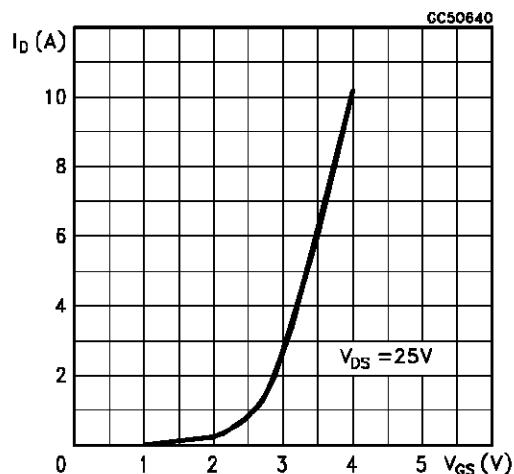
Derating Curve



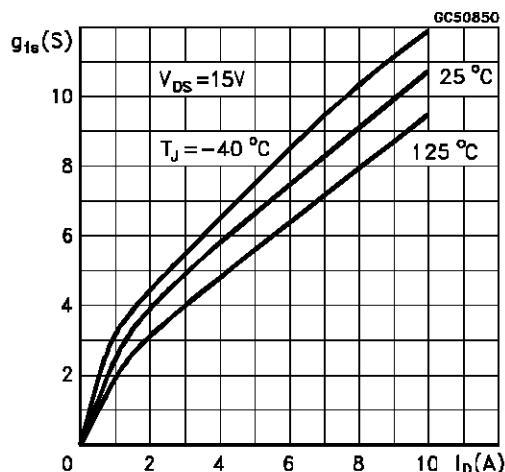
Output Characteristics



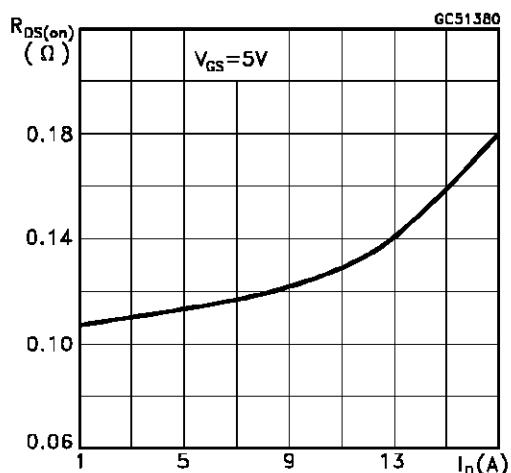
Transfer Characteristics



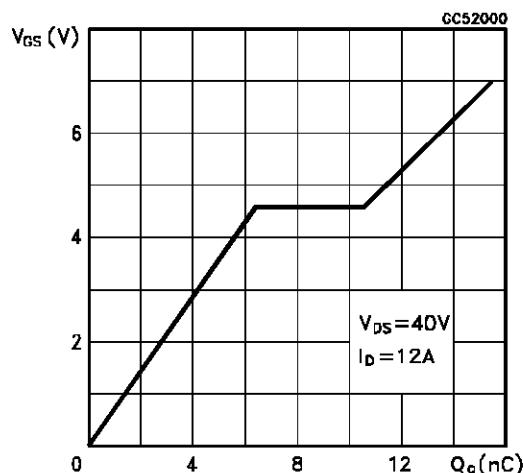
Transconductance



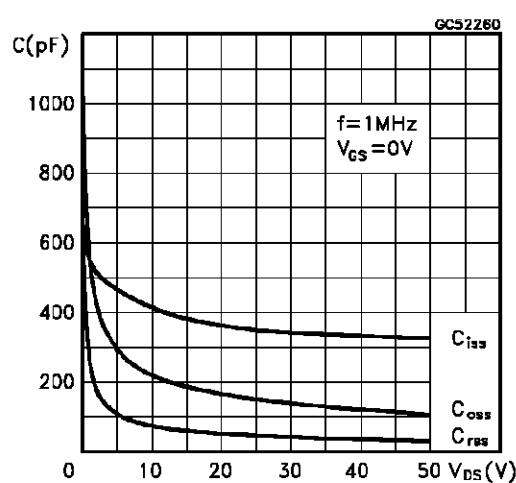
Static Drain-source On Resistance



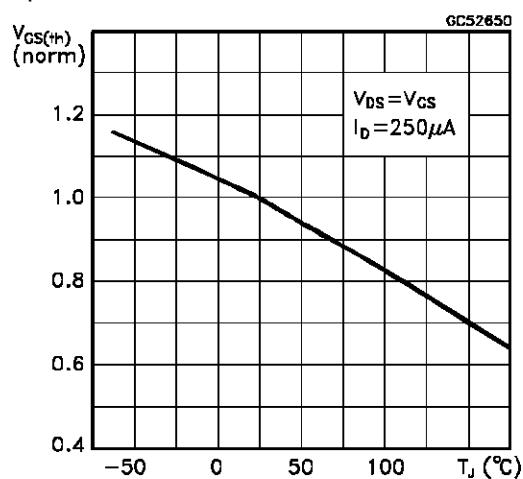
Gate Charge vs Gate-source Voltage



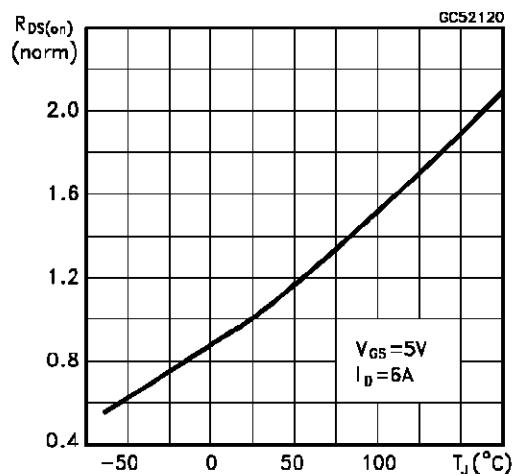
Capacitance Variations



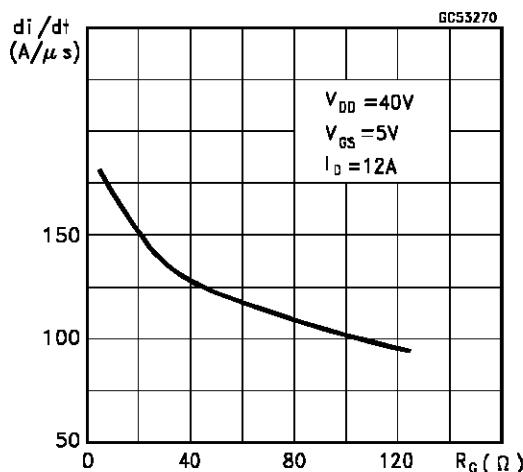
Normalized Gate Threshold Voltage vs Temperature



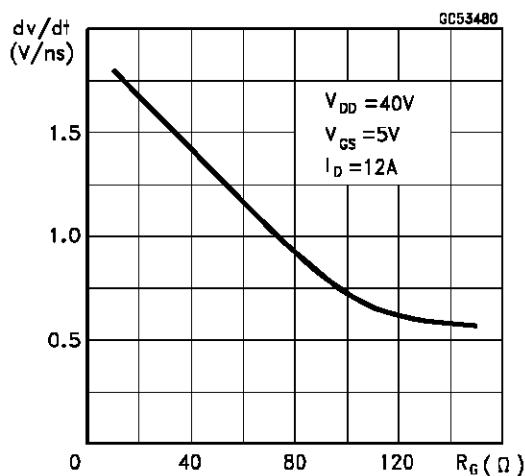
Normalized On Resistance vs Temperature



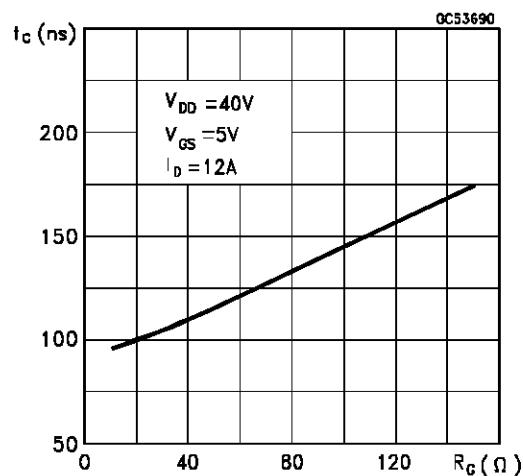
Turn-on Current Slope



Turn-off Drain-source Voltage Slope

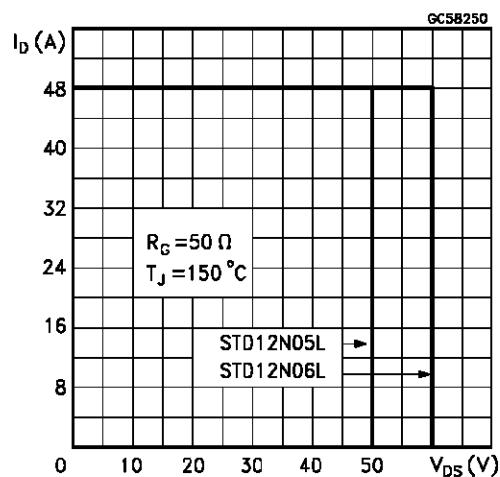


Cross-over Time

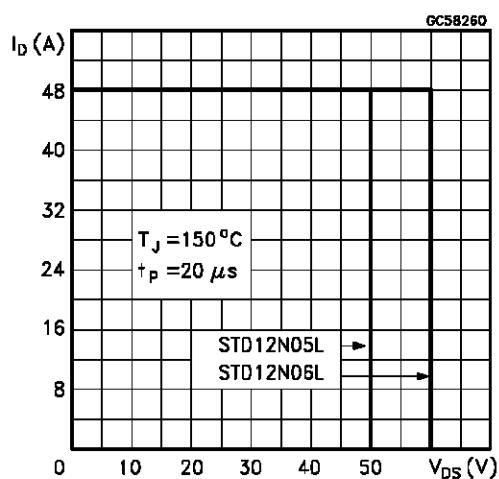


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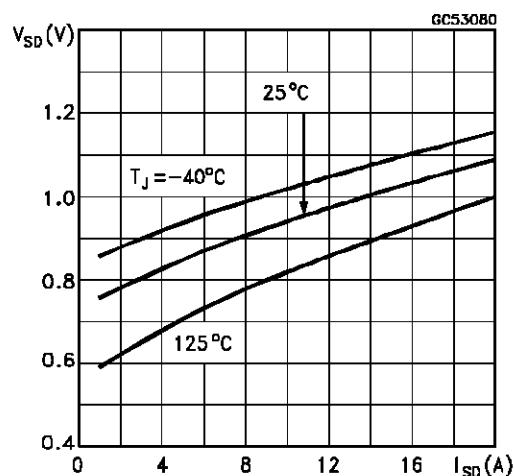
Switching Safe Operating Area



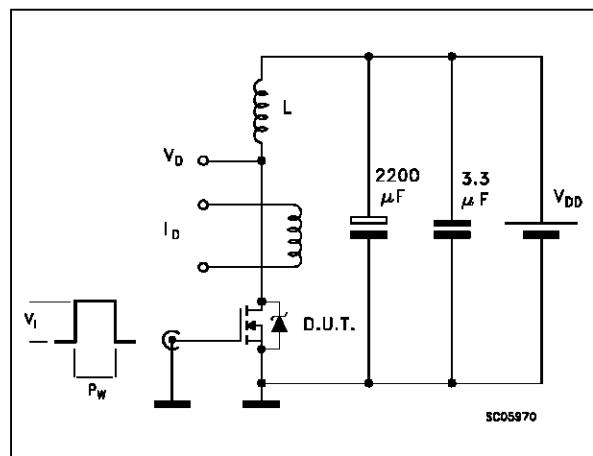
Accidental Overload Area



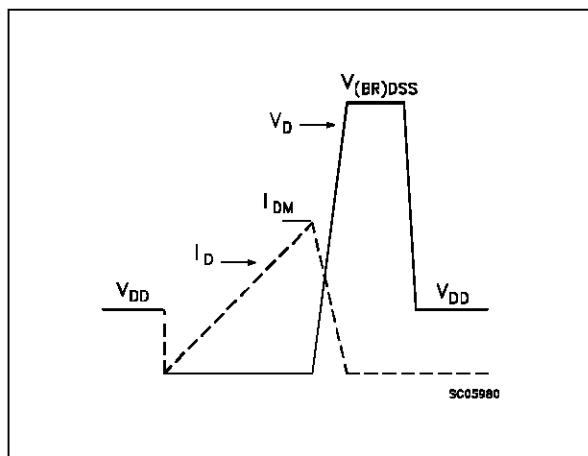
Source-drain Diode Forward Characteristics



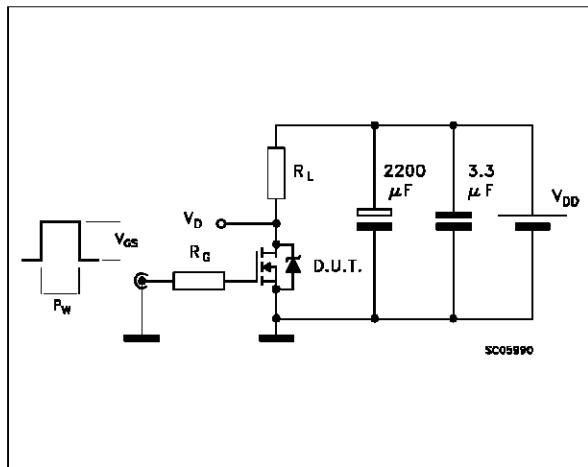
**Fig. 1:** Unclamped Inductive Load Test Circuits



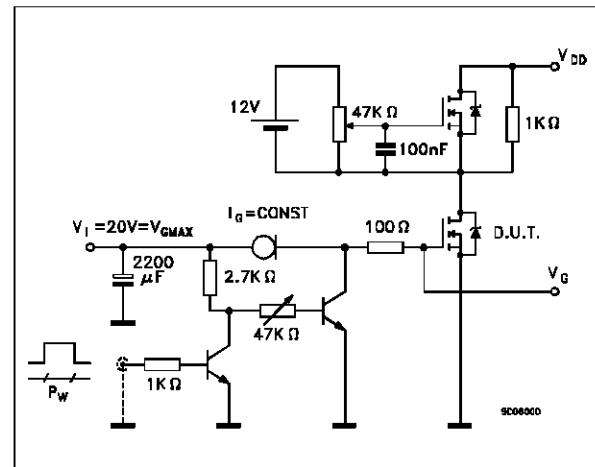
**Fig. 2:** Unclamped Inductive Waveforms



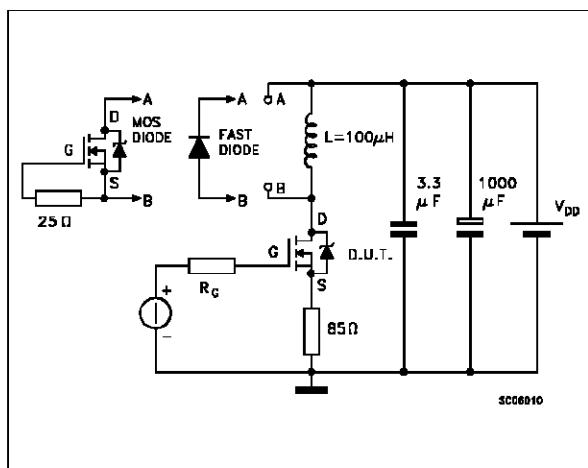
**Fig. 3:** Switching Times Test Circuits For Resistive Load



**Fig. 4:** Gate Charge Test Circuit

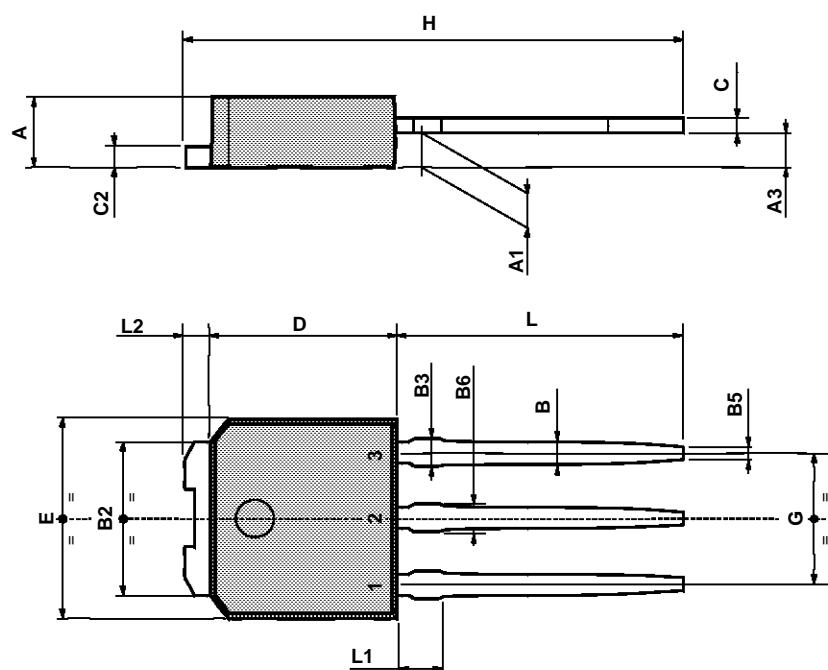


**Fig. 5:** Test Circuit For Inductive Load Switching And Diode Reverse Recovery Time



## TO-251 (IPAK) MECHANICAL DATA

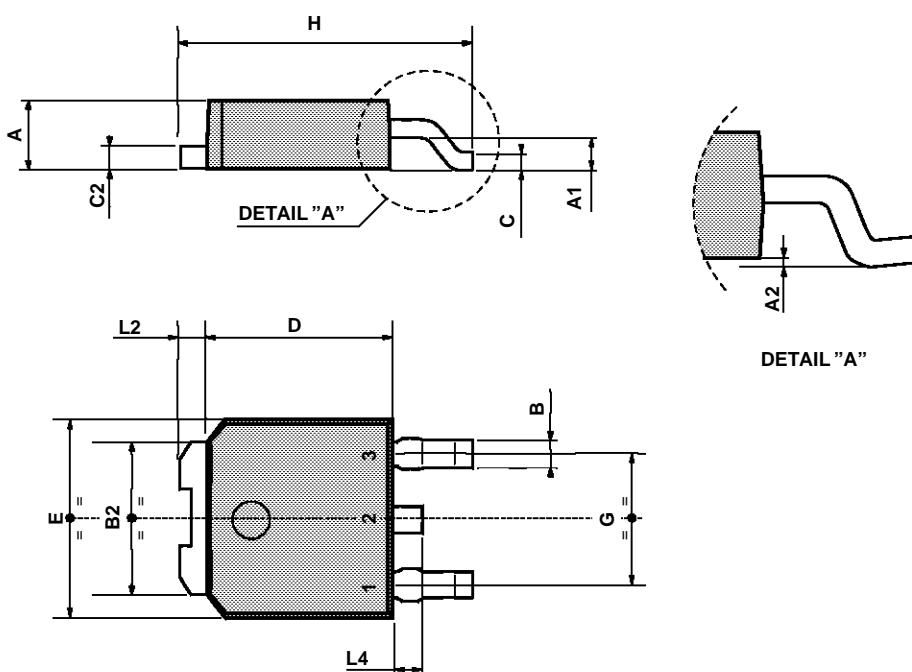
| DIM. | mm   |      |      | inch  |       |       |
|------|------|------|------|-------|-------|-------|
|      | MIN. | TYP. | MAX. | MIN.  | TYP.  | MAX.  |
| A    | 2.2  |      | 2.4  | 0.086 |       | 0.094 |
| A1   | 0.9  |      | 1.1  | 0.035 |       | 0.043 |
| A3   | 0.7  |      | 1.3  | 0.027 |       | 0.051 |
| B    | 0.64 |      | 0.9  | 0.025 |       | 0.031 |
| B2   | 5.2  |      | 5.4  | 0.204 |       | 0.212 |
| B3   |      |      | 0.85 |       |       | 0.033 |
| B5   |      | 0.3  |      |       | 0.012 |       |
| B6   |      |      | 0.95 |       |       | 0.037 |
| C    | 0.45 |      | 0.6  | 0.017 |       | 0.023 |
| C2   | 0.48 |      | 0.6  | 0.019 |       | 0.023 |
| D    | 6    |      | 6.2  | 0.236 |       | 0.244 |
| E    | 6.4  |      | 6.6  | 0.252 |       | 0.260 |
| G    | 4.4  |      | 4.6  | 0.173 |       | 0.181 |
| H    | 15.9 |      | 16.3 | 0.626 |       | 0.641 |
| L    | 9    |      | 9.4  | 0.354 |       | 0.370 |
| L1   | 0.8  |      | 1.2  | 0.031 |       | 0.047 |
| L2   |      | 0.8  | 1    |       | 0.031 | 0.039 |



0068771-E

## **TO-252 (DPAK) MECHANICAL DATA**

| DIM. | mm   |      |      | inch  |       |       |
|------|------|------|------|-------|-------|-------|
|      | MIN. | TYP. | MAX. | MIN.  | TYP.  | MAX.  |
| A    | 2.2  |      | 2.4  | 0.086 |       | 0.094 |
| A1   | 0.9  |      | 1.1  | 0.035 |       | 0.043 |
| A2   | 0.03 |      | 0.23 | 0.001 |       | 0.009 |
| B    | 0.64 |      | 0.9  | 0.025 |       | 0.035 |
| B2   | 5.2  |      | 5.4  | 0.204 |       | 0.212 |
| C    | 0.45 |      | 0.6  | 0.017 |       | 0.023 |
| C2   | 0.48 |      | 0.6  | 0.019 |       | 0.023 |
| D    | 6    |      | 6.2  | 0.236 |       | 0.244 |
| E    | 6.4  |      | 6.6  | 0.252 |       | 0.260 |
| G    | 4.4  |      | 4.6  | 0.173 |       | 0.181 |
| H    | 9.35 |      | 10.1 | 0.368 |       | 0.397 |
| L2   |      | 0.8  |      |       | 0.031 |       |
| L4   | 0.6  |      | 1    | 0.023 |       | 0.039 |



0068772-B

## **STD12N05L/STD12N06L**

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